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Radiation Hard Multijunction Component Development at NREL



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Multijunctions at NREL



Outline

3-Junction IMM



Component Development

- Metamorphic GalnAsP
 - replace radiation-soft GaAs or GaInAs
- Graded Buffer Bragg Reflector
 - enable thin GaAs subcell without dedicated DBR
- GaAs subcell improvements
 - strain-balanced solar cells



Metamorphic GalnAsP



Metamorphic GalnAsP

- Wide range of accessible bandgaps
- Lattice-matched GaInAsP previously studied, shown to be radiation hard
- Limited work on lattice-mismatched GaInAsP





GaInAsP solar cells: Sharps, IEEE PVSC, 1991

Lattice-mismatched GaInAsP

- Drop-in replacements for IMM or UMM subcells
 - 1.4 eV GaAs, 1.0 eV GaInAs, for example
- Study radiation hardness vs alloy content





TEM of lattice-mismatched GaInAsP



[-110] ——

[001]

TEM courtesy of B. Haidet, K. Mukherjee, UCSB

Defects: stacking faults and dislocations

Cross-sectional TEM BF STEM

- GalnAsP separates into InAs-rich and GaP-rich regions
- Composition nonuniformity leads to defects at GaInAsP – GaInP BSF interface
- High defect density > 5 x10⁷/ cm²



NREL | 7

CL and IV of improved 1.0-eV GaInAsP

- Initial GaInAsP is highly defective due to composition modulation
- Limiting composition nonuniformity via growth conditions avoids defect formation, improves device performance
 - High V/III ratio, high growth rate, reduced thickness
 - ----- Standard 1.0 eV GaInAs
 - Initial 1.0 eV GaInAsP
 - Improved 1.0 eV GaInAsP: less composition nonuniformity

Plan-view cathodoluminescence



Metamorphic GaInAsP cell results

- GaInAsP has a tunable bandgap \rightarrow enables higher current than GaAs
- Excellent EQE and IQE for GaInAsP with both 0.95 and 1.35-eV
- Phosphorous contents up to 40% demonstrated \rightarrow potentially higher rad tolerance



GalnAsP subcell in 3J IMM



- Total Voc is high, GaInAsP Woc = 0.40 (from EL),
- Excellent carrier collection (no ARC) •
- No loss in GaInAsP subcell performance in a multijunction



Graded Buffer Bragg Reflectors



Graded Buffer + Bragg Reflector = GBBR

Compositionally Graded Buffer (CGB) Other active Threading subcells dislocation Passivating layers p-n junction Misfit dislocations Overshoot layer Compositionally graded buffer Substrate/ 500 nm Growth active X-sectional TEM direction subcell Lattice constant

- Grades the lattice constant to metamorphic material with desired bandgap
- Strain relieved via dislocation glide

R.M. France et al., Metamorphic Epitaxy for Multijunction Solar Cells, MRS Bulletin, 41, 202 (2016).

Distributed Bragg Reflector (DBR)



- DBR aids collection in an optically thin subcells
 - Low diffusion length
 - High bulk recombination
 - Radiation hardness
 - Quantum wells
- Alternating layers with refractive index contrast

Design and TEM of AlGaInAs GBBR



Design:

- Slowly increase Indium-content to increase lattice constant
- Alternate Aluminum-content for refractive index contrast

Cross-sectional TEM:

- No noticeable affect of alternating Al on dislocations
- Low threading dislocation density



GaInP/GaAs

Low Al High Al Low Al High Al Low Al High Al

scalebə 200 nm

Reflectance and Dislocation Density of GBBR



Vary thickness of GBBR, compare to controls

- Minor increase in Woc, TDD wrt control
- Reflectance increases and Woc, TDD decreases with increasing buffer thickness, as expected
- Over 99% reflectance possible in GBBR



Triple GBBR for radiation-hard, thin GaAs



- GBBR enables thin GaAs for improved radiation hardness
- Jsc increased by 1.5 mA/cm² under AM0 compared to baseline 800 nm thick GaAs cell without GBBR

GBBRBandwidthJsc increasedesign(nm)(mA/cm²)1xGBBR651.03xGBBR1401.5

3J-IMM + MQW demonstration



 GBBR allows second pass through MQWs, which increase sub-bandgap absorption

Photocurrents from EQE (mA/cm²)

	Global	Direct	AM0
J1	15.6	15	19.4
J2	16.2	16.6	18.1
J3	14.4	15.2	18.4
J2 QW + GBBR gain	2.0	2.1	2.5

I-V results

	Global	Direct	AM0
Efficiency	36.5	36.6	32.4
Voc	2.93	2.93	2.95

GaAs strain-balanced solar cells



Strain-balanced solar cells

- Excellent EQE and Voc achieved in strainbalanced solar cell
- Sub-bandgap Jsc increase of 3 mA/cm² under space spectrum, am0





2-junction strain-balanced am0 device

SBSL increases BOL efficiency

- Measured without ARC: Jsc = 14.0 mA/cm², Eff. = 21.7%
- Predicted with ARC: Jsc > 19 mA/cm², Eff. >29%





Summary



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Thank you!

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